

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned

Examiner: To Be Assigned

In re PATENT APPLICATION of

Applicant(s) : Kazutaka SHIBATA

Appln. No. : To Be Assigned

Filed : June 30, 2003

For : SEMICONDUCTOR DEVICE AND
MANUFACTURING METHOD THEREOF)

Atty. Dkt. : AI 288

**INFORMATION
DISCLOSURE
STATEMENT**

Commissioner for Patents
Washington, D.C. 20231

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

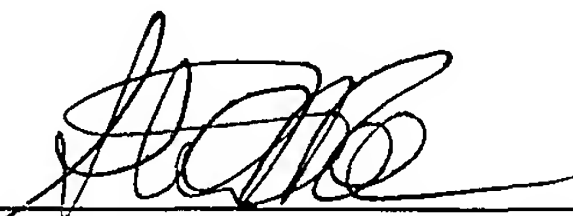
Attached are copies of two Japanese patent publications. A Japanese publication No. 2002-118199 can be gleaned from the attached English-language Abstract. Japanese Laid-Open patent publication No. 11-150090 is described on page 2 of the specification. The documents are listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the documents submitted. Consideration of the submitted documents is respectfully requested.

Respectfully submitted,

June 30, 2003
Date

SMR:tl


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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty Docket AI 288		Application No. To Be Assigned			
				Applicant Kazutaka SHIBATA					
				Filing Date June 30, 2003				Group Unit To Be Assigned	
U.S. PATENT DOCUMENTS									
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date		
	AA								
	AB								
	AC								
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	AG								
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FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country	Class	Sub-Class	Trans-lation		
	AL	2002-118199	04/19/02	Japan			Abstract		
	AM	11-150090	06/02/99	Japan					
	AN								
	AO								
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)									
	AP								
	AQ								
	AR								
Examiner						Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.									